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Critical Density for Coverage and Connectivity in Two-Dimensional Aligned-Orientation Directional Sensor Networks Using Continuum Percolation

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Abstract

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Sensing coverage is one of the fundamental design issues in wireless sensor networks as it determines the surveillance quality provided by them. Moreover, network connectivity ensures that all nodes in the network can communicate with each other directly or indirectly via other nodes. In this paper, we study the critical density for coverage and connectivity in two-dimensional aligned-orientation directional sensor networks (ALODSN) using continuum percolation theory. We introduce a new model for ALODSN based on Poisson Point Process and the orientation of all sensor nodes is the same. We propose an approach to compute density of nodes at critical percolation for both NCPT and CCPT problems in such networks, for all angles of field-of-view between and

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percolation. Due to percolation theory, the critical density is infimum density t SCPT and NCPT almost surely occur. Also, we propose a model for percolat networks which provides a basis for solving the SCPT and NCPT problems to

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